

512K (32K x 16) Static RAM

Features

- Pin- and function-compatible with CY7C1020B
- High speed
 - $t_{AA} = 10 \text{ ns}$
- Low active power
 - $I_{CC} = 80 \text{ mA} @ 10 \text{ ns}$
- Low complementary metal oxide semiconductor (CMOS) standby power
 - $I_{SB2} = 3 \text{ mA}$
- 2.0 V data retention
- Automatic power-down when deselected
- CMOS for optimum speed/power
- Independent control of upper and lower bits
- Available in Pb-free 44-pin 400-Mil wide Molded SOJ and 44-pin thin small outline package (TSOP) II packages

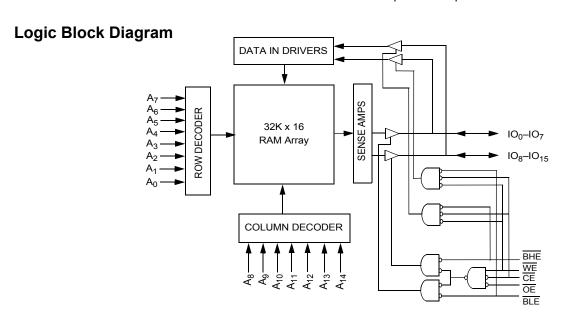
Functional Description [1]

The CY7C1020D is a high-performance CMOS static RAM organized as 32,768 words by 16 bits. This device has an automatic power-down feature that significantly reduces power consumption when deselected. The input and output pins (IO_0 through IO_{15}) are placed in a high-impedance state when:

- Deselected (CE HIGH)
- Outputs are disabled (OE HIGH)
- BHE and BLE are disabled (BHE, BLE HIGH)
- When the write operation is active (CE LOW, and WE LOW)

Write to the device by taking Chip Enable (\overline{CE}) and Write Enable (\overline{WE}) inputs LOW. If Byte Low Enable (\overline{BLE}) is LOW, then data from IO pins $(IO_0$ through $IO_7)$, is written into the location specified on the address pins $(A_0$ through $A_{14})$. If Byte High Enable (\overline{BHE}) is LOW, then data from IO pins $(IO_8$ through $IO_{15})$ is written into the location specified on the address pins $(A_0$ through $A_{14})$.

Reading from the device by taking Chip Enable (CE) and Output Enable ($\overline{\text{OE}}$) LOW while forcing the Write Enable ($\overline{\text{WE}}$) HIGH. If Byte Low Enable ($\overline{\text{BLE}}$) is LOW, then data from the memory location specified by the address pins appears on IO $_0$ to IO $_7$. If Byte High Enable ($\overline{\text{BHE}}$) is LOW, then data from memory appears on IO $_8$ to IO $_{15}$. See the "Truth Table" on page 9 for a complete description of read and write modes.



Note

1. For guidelines on SRAM system design, please refer to the 'System Design Guidelines' Cypress application note, available on the internet at www.cypress.com.

CY7C1020D



Contents

Pin Configurations	3
Selection Guide	
Maximum Ratings	4
Operating Range	4
Electrical Characteristics	
Capacitance	
Thermal Resistance	
AC Test Loads and Waveforms	5
Switching Characteristics	6
Data Retention Waveform	
Switching Waveforms	
•	0

Ordering Information	10
Ordering Code Definitions	10
Package Diagrams	11
Acronyms	13
Document Conventions	13
Units of Measure	13
Document History Page	14
Sales, Solutions, and Legal Information	
Worldwide Sales and Design Support	15
Products	
PSoC Solutions	15



Pin Configurations^[2]

SOJ/TSOP II Top View

NC ☐ 1	44 □ A ₅
$A_3 \square 2$	43 🗖 A ₆
A ₂ □ 3	42 🗖 🗛
A ₁	41 🗖 ŌE
A ₀	40 ☐ BHE
CE ☐ 6	39 ☐ BLE
IO ₀	38 ☐ IO ₁₅
IO ₁	37 🗆 IO ₁₄
IO ₂	36 🗆 IO ₁₃
IO ₃	35 🗆 IO ₁₂
V _{CC} □11	34 □ V _{SS}
V _{SS}	33 ☐ V _{CC}
IO ₄	32 □ IO ₁₁
IO ₅	31 □ IO ₁₀
IO ₆ 15	30 ☐ IO ₉
IO ₇ □ 16	29 🗆 IO ₈
WE □ 17	28 🗆 NC
A ₄ □ 18	27 🗖 A ₈
A ₁₄ ☐ 19	26 🗆 A ₉
A ₁₃ □20	25 🛮 A ₁₀
A ₁₂ □21	24 🛭 A ₁₁
NC □22	23 🗆 NC

Selection Guide

	–10 (Industrial)	Unit
Maximum access time	10	ns
Maximum operating current	80	mA
Maximum CMOS standby current	3	mA

Note

2. NC pins are not connected on the die.



Maximum Ratings

DC input voltage [3]	-0.5 V to V _{CC} + 0.5 V
Current into outputs (LOW)	20 mA
Static discharge voltage(per MIL-STD-883, Method 3015)	>2001 V
Latch-up current	>200mA

Operating Range

Range Ambient Temperature		V _{CC}	Speed
Industrial	–40 °C to +85 °C	$5~V\pm0.5~V$	10 ns

Electrical Characteristics (Over the Operating Range)

Doromotor	Description	Test Conditions		–10 (lı	l lmi4	
Parameter	Description	rest Conditions		Min	Max	Unit
V _{OH}	Output HIGH voltage	I _{OH} = -4.0 mA		2.4	_	V
V _{OL}	Output LOW voltage	I _{OL} = 8.0 mA		_	0.4	V
V _{IH}	Input HIGH voltage	-		2.2	V _{CC} + 0.5V	V
V _{IL}	Input LOW voltage [3]	-		-0.5	0.8	V
I _{IX}	Input load current	$GND \le V_1 \le V_{CC}$	$GND \le V_1 \le V_{CC}$			μΑ
I _{OZ}	Output leakage current	$GND \le V_1 \le V_{CC}$, output disabled	d	– 1	+1	μА
I _{CC}	V _{CC} operating supply current	V _{CC} = Max,	100 MHz	_	80	mA
		$I_{OUT} = 0 \text{ mA},$ $f = f_{max} = 1/t_{RC}$	83 MHz	_	72	mA
			66 MHz	_	58	mA
			40 MHz	_	37	mA
I _{SB1}	Automatic CE power-down current—TTL inputs	$\begin{aligned} &\text{Max V}_{CC}, \overline{CE} \geq \text{V}_{IH} \\ &\text{V}_{IN} \geq \text{V}_{IH} \text{ or V}_{IN} \leq \text{V}_{IL}, f = f_{max} \end{aligned}$		-	10	mA
I _{SB2}	Automatic CE Power-Down current—CMOS inputs	$\begin{aligned} &\text{Max V}_{CC}, \overline{CE} \geq \text{V}_{CC} - 0.3\text{V}, \\ &\text{V}_{\text{IN}} \geq \text{V}_{CC} - 0.3\text{V}, \text{ or V}_{\text{IN}} \leq 0.3\text{V}, \end{aligned}$	f = 0	-	3	mA

Note

Document #: 38-05463 Rev. *G

^{3.} V_{IL} (min) = -2.0 V and V_{IH} (max) = V_{CC} + 1 V for pulse durations of less than 5 ns.



Capacitance [4]

Parameter	arameter Description Test Conditions		Max	Unit
C _{IN}	Input capacitance	$T_A = 25 ^{\circ}\text{C}$, $f = 1 \text{MHz}$, $V_{CC} = 5.0 \text{V}$	8	pF
C _{OUT}	Output capacitance		8	pF

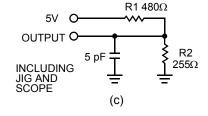
Thermal Resistance [4]

Parameter	Description	Test Conditions	SOJ	TSOP II	Unit
Θ_{JA}		Still Air, soldered on a 3 × 4.5 inch, four-layer printed circuit board	59.52	53.91	°C/W
$\Theta_{\sf JC}$	Thermal resistance (junction to case)		36.75	21.24	°C/W

AC Test Loads and Waveforms [5]



High-Z characteristics:



- Notes

 4. Tested initially and after any design or process changes that may affect these parameters.

 4. Tested initially and after any design or process changes that may affect these parameters.
- 5. AC characteristics (except High-Z) are tested using the load conditions shown in Figure (a). High-Z characteristics are tested for all speeds using the test load shown in Figure (c).



Switching Characteristics (Over the Operating Range) [6]

	Post of the	-10 (Inc	dustrial)	
Parameter	Description	Min	Max	Unit
Read Cycle		,		'
t _{power} [7]	V _{CC} (typical) to the first access	100	_	μS
t _{RC}	Read cycle time	10	_	ns
t _{AA}	Address to data valid	_	10	ns
t _{OHA}	Data hold from address change	3	_	ns
t _{ACE}	CE LOW to data valid	-	10	ns
t _{DOE}	OE LOW to data valid	-	5	ns
t _{LZOE}	OE LOW to Low Z [9]	0		ns
t _{HZOE}	OE HIGH to High Z [8, 9]	-	5	ns
t _{LZCE}	CE LOW to Low Z [9]	3	_	ns
t _{HZCE}	CE HIGH to High Z [8, 9]	_	5	ns
t _{PU} ^[10]	CE LOW to power-up	0	_	ns
t _{PD} ^[10]	CE HIGH to power-down	_	10	ns
t _{DBE}	Byte enable to data valid		5	ns
t _{LZBE}	Byte enable to Low Z	0	_	ns
t _{HZBE}	Byte disable to High Z	-	5	ns
Write Cycle [11, 12]				- 1
t _{WC}	Write cycle time	10	_	ns
t _{SCE}	CE LOW to write end	7	_	ns
t _{AW}	Address set-up to write end	7	_	ns
t _{HA}	Address hold from write end	0	_	ns
t _{SA}	Address set-up to write start	0	_	ns
t _{PWE}	WE pulse width	7	_	ns
t _{SD}	Data set-up to write end	6	_	ns
t _{HD}	Data hold from write end	0	_	ns
t _{LZWE}	WE HIGH to Low Z [9]	3	_	ns
t _{HZWE}	WE LOW to High Z [8, 9]	_	5	ns
t _{BW}	Byte enable to end of write	7	_	ns

Notes

- Test conditions assume signal transition time of 3 ns or less, timing reference levels of 1.5V, input pulse levels of 0 to 3.0V, and output loading of the specified I_{OL}/I_{OH} and 30-pF load capacitance.
- through and so-fin load expandance.
 through gives the minimum amount of time that the power supply should be at typical V_{CC} values until the first memory access can be performed.
 through through through the power supply should be at typical V_{CC} values until the first memory access can be performed.
 through through through the power supply should be at typical V_{CC} values until the first memory access can be performed.
 through through through through through the power supply should be at typical V_{CC} values until the first memory access can be performed.
 through th
- 10. This parameter is guaranteed by design and is not tested.
- 10. This parameter is guaranteed by design and is not tested.

 11. The internal write time of the memory is defined by the overlap of CE LOW, WE LOW and BHE/BLE LOW. CE, WE and BHE/BLE must be LOW to initiate a write and the transition of these signals can terminate the write. The input data set-up and hold timing should be referenced to the leading edge of the signal that terminates the write.

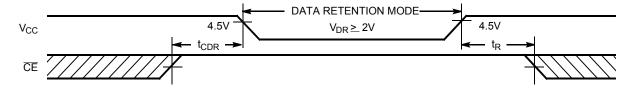
 12. The minimum write cycle time for Write Cycle No. 3 (WE controlled, OE LOW) is the sum of t_{HZWE} and t_{SD}.



Data Retention Characteristics (Over the Operating Range)

Parameter	Description	Conditions	Min	Max	Unit
V_{DR}	V _{CC} for data retention	_	2.0	_	V
I _{CCDR}	Data retention current	$V_{CC} = V_{DR} = 2.0 \text{ V}, \overline{CE} \ge V_{CC} - 0.3 \text{ V},$ $V_{IN} \ge V_{CC} - 0.3 \text{ V or } V_{IN} \le 0.3 \text{ V}$	_	3	mA
t _{CDR} [13]	Chip deselect to data retention time	-	0	-	ns
t _R ^[14]	Operation recovery time	-	t _{RC}	-	ns

Data Retention Waveform



Switching Waveforms

Figure 1. Read Cycle No.1 (Address Transition Controlled) $^{[15,\ 16]}$

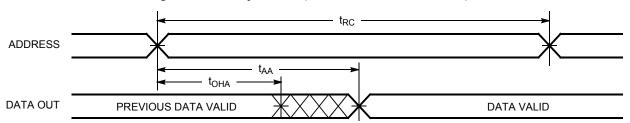
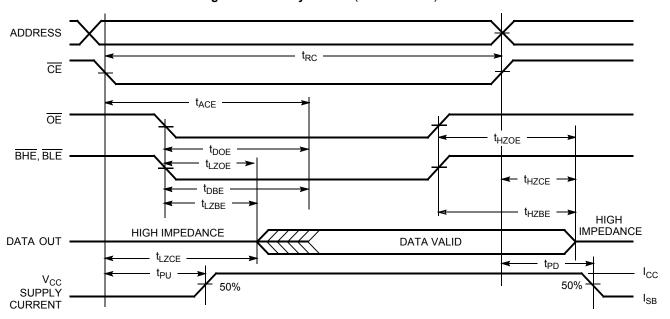


Figure 2. Read Cycle No.2 (OE Controlled) [16, 17]



- Tested initially and after any design or process changes that may affect these parameters.
 Full device operation requires linear V_{CC} ramp from V_{DR} to V_{CC(min)} ≥ 50 μs or stable at V_{CC(min)} ≥ 50 μs.
 Device is continuously selected. OE, CE, BHE and/or BLE = V_{IL}.
- 16. WE is HIGH for read cycle.
- 17. Address valid prior to or coincident with $\overline{\text{CE}}$ transition LOW.



Switching Waveforms(continued)

Figure 3. Write Cycle No. 1 ($\overline{\text{CE}}$ Controlled) [18, 19]

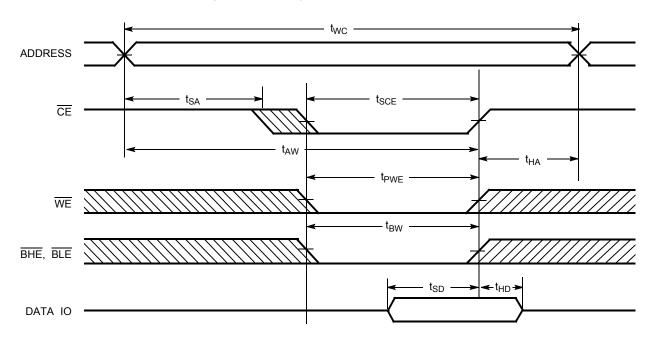
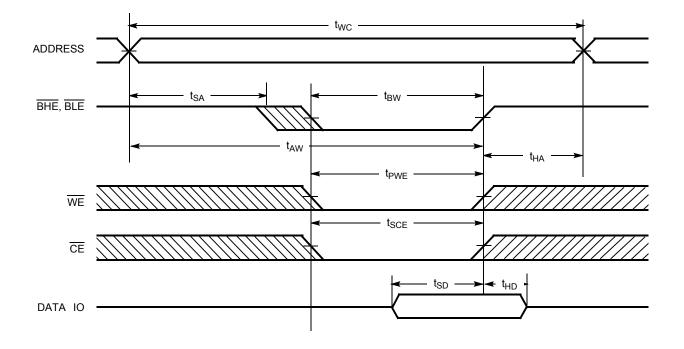


Figure 4. Write Cycle No. 2 (BLE or BHE Controlled) [18, 19]

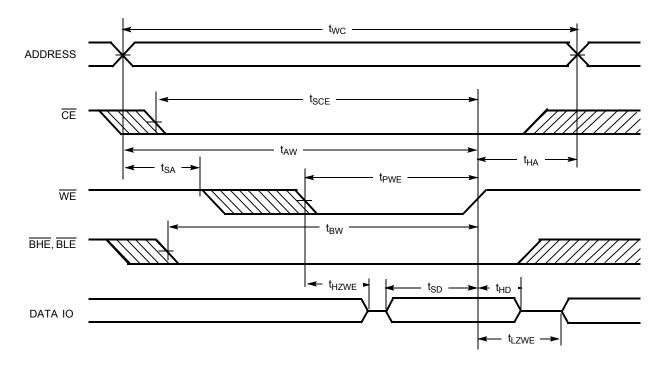


^{18.} Data IO is high impedance if OE or BHE and/or BLE= V_{IH}.
19. If CE goes HIGH simultaneously with WE going HIGH, the output remains in a high-impedance state.



Switching Waveforms(continued)

Figure 5. Write Cycle No. 3 (\overline{WE} Controlled, \overline{OE} LOW) [20, 21]



Truth Table

CE	ŌE	WE	BLE	BHE	IO ₀ –IO ₇	IO ₈ -IO ₁₅	Mode	Power
Н	Х	Х	Х	X	High Z	High Z	Power-down	Standby (I _{SB})
L	L	Н	L	L	Data out	Data out	Read – All bits	Active (I _{CC})
			L	Н	Data out	High Z	Read – Lower bits only	Active (I _{CC})
			Н	L	High Z	Data out	Read – Upper bits only	Active (I _{CC})
L	Х	L	L	L	Data in	Data in	Write – All bits	Active (I _{CC})
			L	Н	Data in	High Z	Z Write – Lower bits only Active (I _{CC})	
			Н	L	High Z	Data in	Write – Upper bits only	Active (I _{CC})
L	Н	Н	X	Х	High Z	High Z	Selected, outputs disabled	Active (I _{CC})
L	Х	Χ	Н	Н	High Z	High Z	selected, outputs disabled	Active (I _{CC})

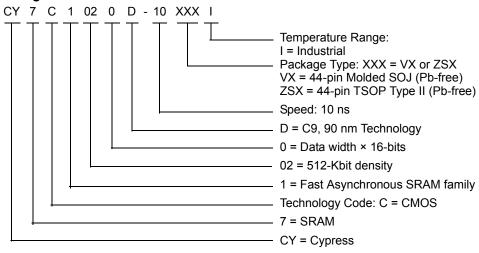
 $[\]begin{array}{l} \textbf{Notes} \\ 20. \ The \ minimum \ write \ cycle \ time \ for \ Write \ \underline{C} \text{ycle No. 3 } (\overline{\text{WE}} \ controlled, \ \overline{\text{OE}} \ LOW) \ is \ the \ sum \ of \ t_{HZWE} \ and \ t_{SD.} \\ 21. \ If \ \overline{\text{CE}} \ goes \ HIGH \ simultaneously \ with \ \overline{\text{WE}} \ going \ HIGH, \ the \ output \ remains \ in \ a \ high-impedance \ state. \\ \end{array}$



Ordering Information

Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range
10	CY7C1020D-10VXI	51-85082	44-pin (400-Mil) Molded SOJ (Pb-free)	Industrial
	CY7C1020D-10ZSXI	51-85087	44-pin TSOP Type II (Pb-free)	

Ordering Code Definitions

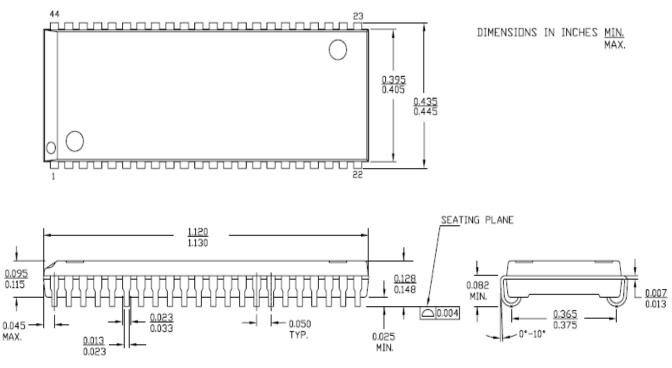


 $\label{prop:prop:prop:prop:prop:sales} Please \ contact \ your \ local \ Cypress \ sales \ representative \ for \ availability \ of \ these \ parts.$



Package Diagrams

Figure 6. 44-pin (400-Mil) Molded SOJ, 51-85082

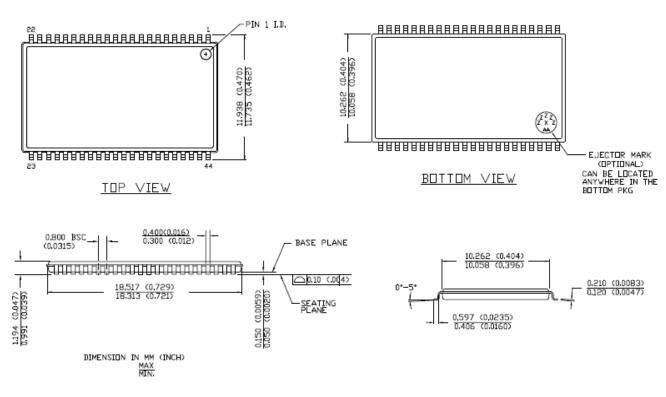


51-85082 *C



Package Diagrams(continued)

Figure 7. 44-Pin Thin Small Outline Package Type II, 51-85087



51-85087 *C

All product and company names mentioned in this document may be the trademarks of their respective holders.



Acronyms

Acronym	Description	
BGA	ball grid array	
CMOS	complementary metal oxide semiconductor	
FBGA	very fine ball gird array	
I/O	input/output	
TSOP	thin small outline package	
SRAM	static random access memory	
TTL	Transistor transistor logic	

Document Conventions

Units of Measure

Symbol	Unit of Measure		
°C	degrees Celsius		
μА	microamperes		
mA	milliampere		
MHz	megahertz		
ns	nanoseconds		
pF	picofarads		
V	volts		
Ω	ohms		
W	watts		



Document History Page

Document Title: CY7C1020D, 512K (32K x 16) Static RAM Document #: 38-05463						
REV.	ECN NO.	Issue Date	Orig. of Change	Description of Change		
**	201560	See ECN	SWI	Advance Data sheet for C9 IPP		
*A	233695	See ECN	RKF	DC parameters modified as per EROS (Spec # 01-0216) Pb-free Offering in the 'Ordering Information'		
*B	263769	See ECN	RKF	1) Corrected pin #18 on SOJ/TSOPII Pinout (Page #1) from A ₁₅ to A ₄ 2) Changed IO ₁ - IO ₁₆ to IO ₀ - IO ₁₅ on the Pin-out diagram 3) Added T _{power} Spec in Switching Characteristics Table 4) Added Data Retention Characteristics Table and Waveforms 5) Shaded 'Ordering Information'		
*C	307594	See ECN	RKF	Reduced Speed bins to -10, -12 and -15 ns		
*D	560995	See ECN	VKN	Converted from Preliminary to Final Removed Commercial Operating range Removed 12 ns speed bin Added I _{CC} values for the frequencies 83MHz, 66MHz and 40MHz Updated Thermal Resistance table Updated Ordering Information Table Changed Overshoot spec from V _{CC} +2V to V _{CC} +1V in footnote #3		
*E	802877	See ECN	VKN	Changed I _{CC} specs from 60 mA to 80 mA for 100MHz, 55 mA to 72 mA for 83MHz, 45 mA to 58 mA for 66MHz, 30 mA to 37 mA for 40MHz		
*F	3109992	12/14/2010	AJU	Added Ordering Code Definitions. Updated Package Diagrams.		
*G	3219056	04/07/2011	PRAS	Added TOC Added Acronyms and Units of Measure table. Updated Datasheet as per template.		



Sales, Solutions, and Legal Information

Worldwide Sales and Design Support

Cypress maintains a worldwide network of offices, solution centers, manufacturer's representatives, and distributors. To find the office closest to you, visit us at cypress.com/sales.

Products

Automotive cypress.com/go/automotive Clocks & Buffers cypress.com/go/clocks Interface cypress.com/go/interface cypress.com/go/powerpsoc cypress.com/go/plc

Memory cypress.com/go/memory
Optical & Image Sensing cypress.com/go/image
PSoC cypress.com/go/psoc
Touch Sensing cypress.com/go/touch
USB Controllers cypress.com/go/USB
Wireless/RF cypress.com/go/wireless

PSoC Solutions

psoc.cypress.com/solutions PSoC 1 | PSoC 3 | PSoC 5

© Cypress Semiconductor Corporation, 2010-2011. The information contained herein is subject to change without notice. Cypress Semiconductor Corporation assumes no responsibility for the use of any circuitry other than circuitry embodied in a Cypress product. Nor does it convey or imply any license under patent or other rights. Cypress products are not warranted nor intended to be used for medical, life support, life saving, critical control or safety applications, unless pursuant to an express written agreement with Cypress. Furthermore, Cypress does not authorize its products for use as critical components in life-support systems where a malfunction or failure may reasonably be expected to result in significant injury to the user. The inclusion of Cypress products in life-support systems application implies that the manufacturer assumes all risk of such use and in doing so indemnifies Cypress against all charges.

Any Source Code (software and/or firmware) is owned by Cypress Semiconductor Corporation (Cypress) and is protected by and subject to worldwide patent protection (United States and foreign), United States copyright laws and international treaty provisions. Cypress hereby grants to licensee a personal, non-exclusive, non-transferable license to copy, use, modify, create derivative works of, and compile the Cypress Source Code and derivative works for the sole purpose of creating custom software and or firmware in support of licensee product to be used only in conjunction with a Cypress integrated circuit as specified in the applicable agreement. Any reproduction, modification, translation, compilation, or representation of this Source Code except as specified above is prohibited without the express written permission of Cypress.

Disclaimer: CYPRESS MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARD TO THIS MATERIAL, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE. Cypress reserves the right to make changes without further notice to the materials described herein. Cypress does not assume any liability arising out of the application or use of any product or circuit described herein. Cypress does not authorize its products for use as critical components in life-support systems where a malfunction or failure may reasonably be expected to result in significant injury to the user. The inclusion of Cypress' product in a life-support systems application implies that the manufacturer assumes all risk of such use and in doing so indemnifies Cypress against all charges.

Use may be limited by and subject to the applicable Cypress software license agreement.

Document #: 38-05463 Rev. *G

Revised April 7, 2011

Page 15 of 15